Product Name	EPIC Express Board
Model Number	xxxxxEPIC-HD07-xxxxxx(Where x is 0-9 , A-Z , -or blank)
	for marketing purpose
Applicant	AAEON Technology Inc.
Address	5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist,
	New Taipei City, Taiwan, R.O.C.
Report Number	F-U070-1204-130
Issue Date	April 24, 2012
Applicable Standards	FCC Part 15, Subpart B Class A ITE ANSI C63.4:2003 Industry Canada ICES-003 Issue 4 CSA-IEC CISPR22: 02 Class A ITE

One sample of the designated product has been tested in our laboratory and found to be in compliance with the FCC rules cited above.





NVLAP LAB CODE 200575-0

TAF 0905 FCC CAB Code TW1053 IC Code 4699A VCCI Accep. No. R-1527, C-1609, T-1441, G-10



Central Research Technology Co. EMC Test Laboratory 11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C. Tel : 886-2-25984568 Fax: 886-2-25984546

J. J. Ull

(Tsun-Yu Shih/ General Manager) Date: <u>April 24, 2012</u>

FCC Test Report

for

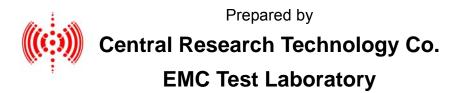
EPIC Express Board

Model Number :	xxxxxEPIC-HD07-xxxxxx
	(Where x is 0-9,A-Z,-or blank)
	for marketing purpose
Report Number :	F-U070-1204-130
Date of Receipt :	April 11, 2012
Date of Report :	April 24, 2012

Prepared for

AAEON Technology Inc.

5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist, New Taipei City, Taiwan, R.O.C.



11, Lane 41, Fushuen St., Jungshan Chiu, Taipei, Taiwan, 104, R.O.C.



NVLAP LAB CODE 200575-0

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Verification of Compliance

Equipment Under Test	: EF	PIC Express Board			
Model No.	: xx	xxxxEPIC-HD07-xxxxxx			
	(V)	Where x is 0-9 $,$ A-Z $,$ -or blank) for marketing purpose			
Applicant	: A/	AEON Technology Inc.			
Address	: 5F	F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist, New			
	Та	aipei City, Taiwan, R.O.C.			
Applicable Standards	: FC	CC Part 15, Subpart B Class A ITE			
	A	NSI C63.4:2003			
	In	dustry Canada ICES-003 Issue 4			
	CS	SA-IEC CISPR22: 02 Class A ITE			
Date of Testing	: Ap	pril 13~20, 2012			
Deviation	: N/	/A FC			
Condition of Test Sample	: Er	ngineering Sample			

We, **Central Research Technology Co**., hereby certify that one sample of the designated product was tested in our facility during the period mentioned above. The test records, data evaluation and Equipment Under Test (EUT) configurations shown in the present report are true and accurate representation of the measurements of the sample's EMC characteristics under the conditions herein specified.

The test results show that the EUT as described in the present report is in compliance with the requirements set forth in the standards mentioned above and apply to the tested sample identified in the present report only. The test report shall not be reproduced, except in its entirety, without the written approval of Central Research Technology Co.

PREPARED BY	:	Rosa Hs	<u>a H</u> ieh/Sys	tem Executive)	[,] DATE :	April	>4,2012
APPROVED BY	:	J. (Tsun-Yu	Y. Shih/G	eneral Manager	_ • DATE :	Apr,	14, 2012

Contents

1.	Gene	eral Description	4
	1.1	General Description of EUT	4
	1.2	Test Mode	5
	1.3	Applied standards	6
	1.4	Test Setup for the EUT	7
	1.5	The Support Units	8
	1.6	Layout of the Setup	10
	1.7	Test Capability	12
2.	Cond	Jucted Emission Measurement	14
	2.1	Limits for Emission Measurement	14
	2.2	Test Instruments	15
	2.3	Test Procedures	. 17
	2.4	Test Configurations	18
	2.5	Photographs of the Test Configurations	19
	2.6	Test Results	20
3.	Radi	ated Emission Measurement	22
	3.1	Limits for Emission Measurement	. 22
	3.2	Test Instruments	23
	3.3	Test Procedures	26
	3.4	Test Configurations	27
	3.5	Photographs of the Test Configurations	28
	3.6	Test Results	29
Att	achm	ent 1 Photographs of EUT	33
Att	achm	ent 2 Modifications of EUT	37

1. General Description

1.1 General Description of EUT

Equipment Under Test	:	EPIC Express Board			
Model No.	:	xxxxxEPIC-HD	07-xx	xxxxx	
		(Where x is 0-	9 , A	A-Z [,] -or blank)	
		for marketing	purp	ose	
Power in	:	120V/60Hz to	the p	power adapter	
Power Adapter Specification	:	Trade Name	:	FSP	
		Model No.	:	FSP60-DBAB1	
		Input	:	100-240V, 1.5A,50~60Hz	
		Output	:	12Vdc, 5A MAX	
Highest Operating Frequency	:	1.65GHz from	the	test specification	
Manufacturer	:	AAEON Techr	nolog	y Inc.	
Function Description	:				

The EUT is an engineering sample of the EPIC Express Board. Please refer to the user's manual for the details.

The I/O ports of EUT are listed below:

No.	I/O Port Type	Quantity
1	D-Sub port	1
2	DVI port	1
3	PS2 port	1
4	USB port	8
5	RS232 port	6
6	LAN port	2
7	Audio input port	1
8	Audio output port	1
9	Mic. port	1

The devices (supplied by the manufacturer) used to assembly a host system are listed below:

Components	Specification	
CPU	AMD G-T56N 1.65GHz	
HDD HITACHI Z5K320-250 250GB		
Memory	DSL [,] DDR3-1066 4G	
OSC	27MHz;25MHz;32.768KHz	
	AC Adapter Manufacturer : FSP	
Devier Currely	AC Adapter Module Number : FSP060-DBAB1	
Power Supply	AC Adapter Power Rating:I/P:100~240VAC, 1.5A,	
	O/P:12Vdc/5A,60Watt	

1.2 Test Mode

Normal operating as the customer's requirement.

The EUT with D-Sub+DVI 1920 x 1200@60Hz resolution to monitor was selected by the manufacturer to be tested herein.

1.3 Applied standards

According to the specifications of the manufacturer and the requirements set in 47CFR Part 15, the applied standards to evaluate the compliance of the EUT are as following, and the measurement procedures specified in ANSI C63.4: 2003 are performed.

According to 47CFR Part 15 Section 15.33(b), the test frequency range of radiated emission measurements are listed below and the EUT herein shall be tested as:

Type of EUT	Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
	Below 1.705	30
	1.705 - 108	1000
	108 - 500	2000
	500 - 1000	5000
		5 th harmonic of the highest
\checkmark	Above 1000	frequency or 40GHz,
		whichever is lower

All the test items are as following:

Applied Standards	Test Items	Results
FCC Part 15, Subpart B	☑ Conducted Emission Measurement	PASS
Class A ITE	☑ Radiated Emission Measurement	PASS

1.4 Test Setup for the EUT

The EUT is an unique unit connected with other necessary accessories and support units listed in the next section. It has been tested against each standard after the following setup steps:

- a. Connect the EUT installed host system and all the support units to the appropriate power source.
- b. Turn on the EUT and all the accessories and support units.
- c. Install an EMC test software into the EUT and execute it under the Windows environment.
- d. The EUT sends "H" patterns to the monitor, which fills the whole screen of it.
- e. The EUT sends messages to the modems.
- f. The EUT reads/writes messages from/to the USB Flash Disk(s).
- g. The EUT send 1kHz audio signal to the earphones.
- h. Another PC sends/ receives messages to/ from the EUT through a Hub by executing the command of "PING".
- i. Repeat and keep setup steps listed above before and during all tests.

EUT I/O ports / Peripherals	Exerciser Program (software)	Version of Program
EUT		
Monitor		
USB Flash Disk(s)	BurnIn Test.exe	V 6.0
Modem		
Earphone & Microphone		

1.5 The Support Units

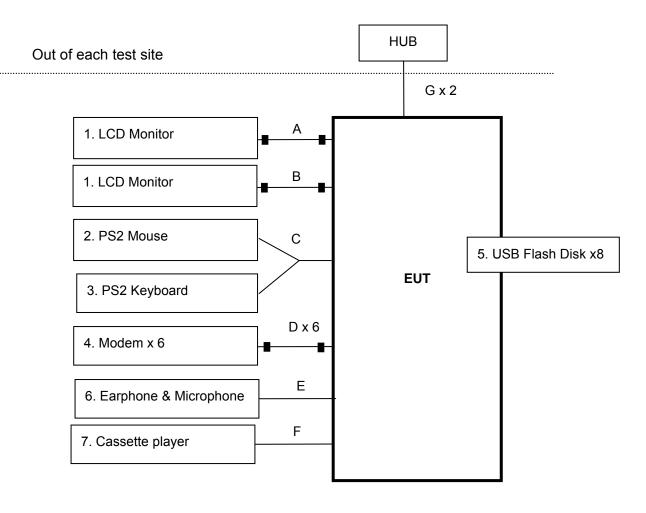
Conducted Emission Test

No.	Unit	Model No./ Serial No.	FCC ID	Trade Name	Power Cord	Supported by lab.
1	Monitor	2408WFP/ CN-0NN792-74261- 849-154S	DoC	DELL	1.8m	✓
1 Mon	Wohito	U2410/ CN-082WXD-72872-12S- 02EL	DoC	DELL	1.8m	~
2	PS/2 Mouse	MO71KC/ 515044954	DoC	DELL	N/A	\checkmark
3	PS/2 Keyboard	SK-8110/ MY-05N456-71619-53A- 0541	DoC	DELL	N/A	~
		DM-1414/ 0311055094	IFAXDH1414	ACEEX	1.9m	✓
		DM-1414/ 0505012779	IFAXDH1414	ACEEX	1.9m	✓
4	Modem	DM-1414/ 0509019802	IFAXDH1414	ACEEX	1.9m	✓
4	wodem	DM-1414/ 0509019801	IFAXDH1414	ACEEX	1.9m	\checkmark
		DM-1414/ 0509019805	IFAXDH1414	ACEEX	1.9m	\checkmark
		DM-1414/ 0609026973	IFAXDH1414	ACEEX	1.9m	\checkmark
		U172/100-038	DoC	PQI	N/A	✓
		U172/100-042	DoC	PQI	N/A	\checkmark
		U172/100-068	DoC	PQI	N/A	\checkmark
5	USB Flash	U172/100-071	DoC	PQI	N/A	✓
Ŭ	Disk	U172/100-074	DoC	PQI	N/A	✓
		U172/100-079	DoC	PQI	N/A	✓
		U172/100-080	DoC	PQI	N/A	\checkmark
		U172/100-098	DoC	PQI	N/A	✓
6	Earphone & Microphone	MIC-4/2008-007	N/A	SCE	N/A	\checkmark
7	Cassette player	RQ-L11/ 4-717523-100921-4	N/A	Panasonic	N/A	✓

Radiated Emission Test

No.	Unit	Model No./ Serial No.	FCC ID	FCC ID Trade Name		Supported by lab.
1	Monitor	U2410/ CN-0J257M-72872-070- 02JL	DoC	DELL	1.8m	~
1	Monitor	U2410/ CN-0J257M-72872-083- 069L	DoC	DELL	1.8m	✓
2	PS/2 Mouse	MO71KC/ 515044954	DoC	DELL	N/A	✓
3	PS/2 Keyboard	SK-8110/ MY-05N456-71619-53A- 0541	DoC	DELL	N/A	✓
		DM-1414/ 0311055094	IFAXDH1414	ACEEX	1.9m	\checkmark
	4 Modem	DM-1414/ 0505012779	IFAXDH1414	ACEEX	1.9m	✓
4		DM-1414/ 0509019802	IFAXDH1414	ACEEX	1.9m	✓
4		DM-1414/ 0509019801	IFAXDH1414	ACEEX	1.9m	✓
		DM-1414/ 0509019805	IFAXDH1414	ACEEX	1.9m	✓
		DM-1414/ 0609026973	IFAXDH1414	ACEEX	1.9m	✓
		U172/100-038	DoC	PQI	N/A	✓
		U172/100-042	DoC	PQI	N/A	\checkmark
		U172/100-068	DoC	PQI	N/A	\checkmark
5	USB Flash	U172/100-071	DoC	PQI	N/A	\checkmark
5	Disk	U172/100-074	DoC	PQI	N/A	\checkmark
		U172/100-079	DoC	PQI	N/A	\checkmark
		U172/100-080	DoC	PQI	N/A	✓
		U172/100-098	DoC	PQI	N/A	✓
6	Earphone & Microphone	E220/20011029-3	N/A	ERGOTECH Technology	N/A	\checkmark
7	Cassette player	RQ-L11/ 4-717523-100921-1	N/A	Panasonic	N/A	✓

1.6 Layout of the Setup



Connecting Cables :

No.	Cable	Length	Shielded	Core	Shielded Backshell	Supported by lab.	Note
А	VGA Cable	1.7m	✓	~		\checkmark	2Cores
В	DVI Cable	1.8m	~	\checkmark		\checkmark	2Cores
С	EUT Connected Cable	0.15m	~				
D	Modem Cable	1.8m	~	✓		\checkmark	2Cores
Е	Earphone & Microphone Cable	1.8m	~			~	
F	Audio Cable	1.5m	\checkmark			\checkmark	
G	LAN Cable	>3m				\checkmark	

1.7 Test Capability

Test Facility

The test facility used for evaluating the conformance of the EUT with each standard in the present report meets what required in CISPR16-1-4, CISPR16-2-3 and ANSI C63.4: 2003.

Test Room	Type of Test Room	Descriptions	
TR1	10m semi-anechoic chamber ($23m \times 14m \times 9m$)	Complying with the NSA requirements in documents CISPR 22 and	
TR11	3m semi-anechoic chamber	ANSI C63.4: 2003. for the radiated	
	$(9m \times 6m \times 6m)$	emission measurement.	
TR5	Shielding Room	For the conducted emission	
IKO	$(8m \times 5m \times 4m)$	measurement.	

Test Laboratory Competence Information

Central Research Technology Co. has been accredited / filed / authorized by the agencies listed in the following table.

Certificate	Nation	Agency	Code	Mark
	USA	NVLAP	200575-0	ISO/IEC 17025
	R.O.C.	TAF	0905	ISO/IEC 17025
	(Taiwan)		0000	100/120 17023
Accreditation			SL2-IN-E-0033,	
Certificate	R.O.C.		SL2-IS-E-0033,	
	(Taiwan)	BSMI	SL2-R1/R2-E-0033,	ISO/IEC 17025
	(Taiwaii)		SL2-A1-E-0033	
			SL2-L1-E-0033	
	USA	FCC	474046,TW1053	Test facility list &
	007	100		NSA Data
Site Filing	Canada	IC	4699A-1,-3	Test facility list &
Document	Canada			NSA Data
	Japan	VCCI	R-1527,C-1609,T-1441,G-10	Test facility list &
	Japan	0001	11-1327,0-1003,1-1441,0-10	NSA Data
Authorization	Germany	TUV	10021687	ISO/IEC 17025
Certificate	Norway	Nemko	ELA 212	ISO/IEC 17025

The copy of each certificate can be downloaded from our web site: <u>www.crc-lab.com</u>

2. Conducted Emission Measurement

Test Result : PASS

2.1 Limits for Emission Measurement

☑ Limits for conducted disturbances at the power mains

Frequency	Class A E	quipment	Class B Equipment				
(MHz)	Quasi-peak	Average	Quasi-peak	Average			
(101112)	(dBµV)	(dBµV)	(dBµV)	(dBµV)			
0.15 to 0.5	79	66	66 – 56	56 – 46			
0.5 to 5	73	60	56	46			
5 to 30	73	60	60	50			
Note 1- The lower limit shall apply at the transition frequency.							
Note 2- The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to							
0.5MHz for Class B equipment.							

2.2 Test Instruments

Test Site and	Manufacturer	Model No./	Last	Calibration	
Equipment	Manufacturer	Serial No.	Calibration Date	Due Date	
Test Receiver	R&S	ESCS 30/	Jan. 11, 2012	Jan. 11, 2013	
Test Receiver	Γασ	836858/021	Jan. 11, 2012	Jan. 11, 2013	
LISN	R&S	ESH2-Z5/	June 2, 2011	luno 2, 2012	
LISIN	Ras	836613/001	Julie 2, 2011	June 2, 2012	
2 nd LISN	R&S	ENV4200/	Marah 26, 2012	March 26, 2013	
2 LISIN	Ras	833209/010	March 26, 2012		
50Ω terminator	N/A	N/A/	Aug 20 2011	Aug. 20, 2012	
SOTT ferminator	N/A	001	Aug. 20, 2011		
RF Switch	N/A	RSU28/	Feb. 20, 2012	Aug 20 2012	
RF SWIICH	N/A	338965/002	Feb. 20, 2012	Aug. 20, 2012	
RF Cable	N/A	N/A/	Fab 20 2012	Aug. 20, 2012	
RF Cable	N/A	C0052 ~ 56	Feb. 20, 2012	Aug. 20, 2012	
Test Software	Audix	e3/	NCR		
	Audix	Ver. 5.2004-2-19k		NCR	
TR5	ETS	TR5/	NCR	NCR	
shielded room	LINDGREN	15353-F		NCK	

Note:

1. The calibrations are traceable to NML/ROC.

2. NCR : No Calibration Required.

Measurement Uncertainty

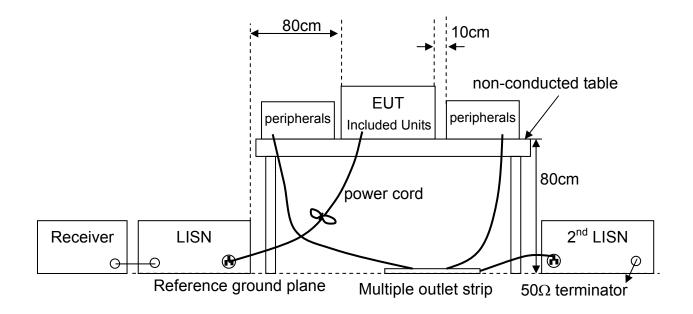
The assessed measurement uncertainty with a suitable coverage factor K to ensure 95% confidence level for the normal distribution are shown as below, the values are less than U_{cispr} in table 1 of CISPR 16-4-2.

Equipment	Model Number	Uncertainty Value		
LISN	ESH2-Z5	3.1dB		
LIGIN	ENV 4200	2.7dB		

2.3 Test Procedures

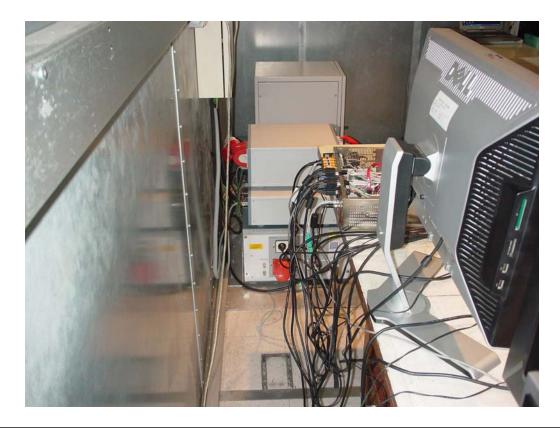
- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a non-conducted table with a height of 0.8 meters above the reference ground plane and 0.4 meters from the conducting wall of the shielded room. Also if the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 12 millimeters above the reference ground plane.
- c. Connect the EUT's power source to the appropriate power mains through the LISN.
- d. All the other peripherals are connected to the 2nd LISN, if any.
- e. The LISN was placed 0.8 meters from the EUT and at least 0.8 meters from other units and other metal planes.
- f. Measure the conducted emissions on each power line (Neutral Line and Line 1 Hot side) of the EUT's power source by using the test receiver connected to the coupling RF output port of LISN.
- g. Rapidly scan the signal from 150kHz to 30MHz by using the receiver through the Maximum-Peak detector to determine those frequencies associated with higher emission levels for each measured line.
- h. Then measure the maximum level of conducted disturbance for each frequency found from step g. by using the receiver through the Quasi-Peak and Average detectors per CISPR 16-1.
- i. Record the level for each frequency and compare with the required limit.

2.4 Test Configurations



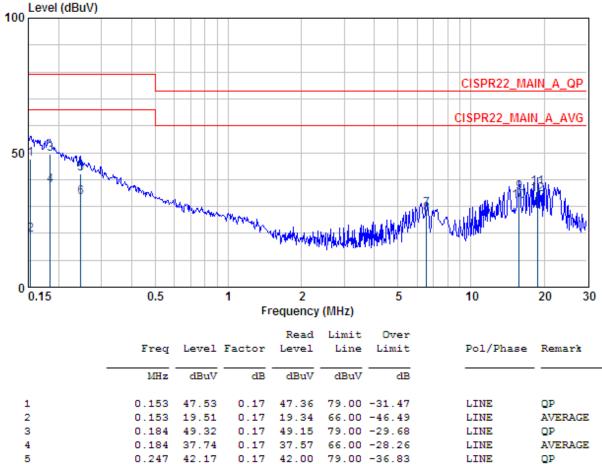


2.5 Photographs of the Test Configurations



2.6 Test Results

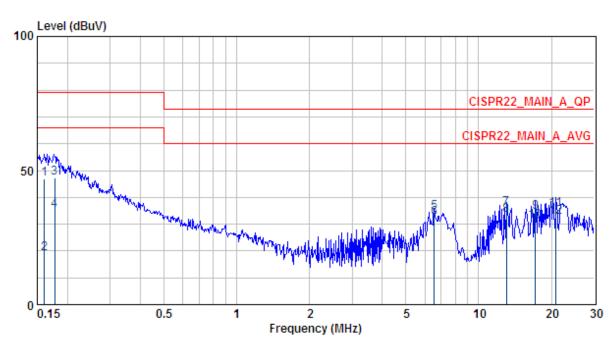
Test Mode	:	As description of section 1.2				
Test Voltage	:	120V/60Hz to the power adapter				
Tester	:	Kent	Temperature	:	26°C	
Humidity	:	71%RH	Frequency Range	:	150kHz~30MHz	
IF Bandwidth	:	9kHz	Phase	:	Line	



-							
5	0.247	42.17	0.17	42.00	79.00 -36.83	LINE	QP
6	0.247	33.49	0.17	33.32	66.00 -32.51	LINE	AVERAGE
7	6.550	28.96	0.49	28.47	73.00 -44.04	LINE	QP
8	6.550	27.23	0.49	26.74	60.00 -32.77	LINE	AVERAGE
9	15.802	35.01	0.93	34.08	73.00 -37.99	LINE	QP
10	15.802	31.74	0.93	30.81	60.00 -28.26	LINE	AVERAGE
11	18.750	36.89	1.09	35.80	73.00 -36.11	LINE	QP
12	18.750	34.52	1.09	33.43	60.00 -25.48	LINE	AVERAGE

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of LISN.
- 3. Q.P. is abbreviation of quasi-peak.

Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to the power adapter					
Tester	:	Kent	Temperature	:	27°C		
Humidity	:	61%RH	Frequency Range	:	150kHz~30MHz		
IF Bandwidth	:	9kHz	Phase	:	Neutral		



	Freq 	Level dBuV	Factor dB	Read Level dBuV	Limit Line dBuV	Over Limit 	Pol/Phase	Remark
1	0.161	46.76	0.16	46.60	79.00	-32.24	NEUTRAL	QP
2	0.161	18.89	0.16	18.73	66.00	-47.11	NEUTRAL	AVERAGE
3	0.177	47.16	0.17	46.99	79.00	-31.84	NEUTRAL	QP
4	0.177	35.33	0.17	35.16	66.00	-30.67	NEUTRAL	AVERAGE
5	6.550	34.40	0.46	33.94	73.00	-38.60	NEUTRAL	QP
6	6.550	32.31	0.46	31.85	60.00	-27.69	NEUTRAL	AVERAGE
7	13.040	35.96	0.63	35.33	73.00	-37.04	NEUTRAL	QP
8	13.040	33.33	0.63	32.70	60.00	-26.67	NEUTRAL	AVERAGE
9	17.127	34.38	0.74	33.64	73.00	-38.62	NEUTRAL	QP
10	17.127	31.31	0.74	30.57	60.00	-28.69	NEUTRAL	AVERAGE
11	20.911	35.69	0.78	34.91	73.00	-37.31	NEUTRAL	QP
12	20.911	32.69	0.78	31.91	60.00	-27.31	NEUTRAL	AVERAGE

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + insertion loss of LISN.
- 3. Q.P. is abbreviation of quasi-peak.

3. Radiated Emission Measurement

Test Result : <u>PASS</u>

3.1 Limits for Emission Measurement

☑ Limits for radiated disturbances below 1000MHz

Frequency	Class A Equipment (10m distance)	Class B Equipment (3m distance)						
(MHz)	Quasi-peak	Quasi-peak						
	(dBµV/m)	(dBµV/m)						
30 to 88	39.1	40						
88 to 216	43.5	43.5						
216 to 960	46.4	46						
960 to 1000	49.5	54						
Note 1- The lower limi	t shall apply at the transition frequency.							
Note 2- Additional pro	visions may be required for cases where	e interference occurs.						
Note 3- According to 1	Note 3- According to 15.109(g), as an alternative to the radiated emission limits shown above, digital							
devices may b	devices may be shown to comply with the standards (CISPR), Pub. 22 shown as below.							
30 to 230	40	30						
230 to 1000	47	37						

□ Limits for radiated disturbances in the frequency range 1000MHz ~ 2000MHz at a measuring distance of 10m

Frequency	Class A Ec	uipment	Class B Equipment		
(GHz)	Peak	Average	Peak	Average	
(GHZ)	(dBµV/m)	(dBµV/m)	(dBµV/m)	(dBµV/m)	
1 to 2	69.5	49.5	63.5	43.5	

☑ Limits for radiated disturbances above 1000MHz at a measuring distance of 3m

Frequency	Class A Ec	uipment	Class B Equipment		
(GHz)	Peak	Average	Peak	Average	
(612)	(dBµV/m)	(dBµV/m)	(dBµV/m)	(dBµV/m)	
1 to 40	80	60	74	54	

3.2 Test Instruments

☑ For Measurement at the distance of 10m

Test Site and Equipment	Manufacturer	Model No./ Serial No.	Last Calibration Date	Calibration Due Date
EMI Test Receiver	R&S	ESCS 30/ 836858/020	Sept. 8, 2011	Sept. 8, 2012
Broadband Antenna	R&S	HL-562/ 360543/007	March 23, 2012	March 23, 2013
Broadband Antenna	R&S	HL-562/ 830547/010	April 26, 2011	April 26, 2012
Pre-Amplifier	Mini Circuit	ZKL-2/ 001	Jan. 17, 2012	July 17, 2012
Pre-Amplifier	Mini Circuit	ZKL-2/ 002	Jan. 17, 2012	July 17, 2012
Spectrum	R&S	FSP7/ 100108	June 10, 2011	June 10, 2012
Spectrum	R&S	FSP7/ 100384	Jan. 3, 2012	Jan. 3, 2013
RF Cable	JYEBAO	0214/ C0049	Jan. 17, 2012	July 17, 2012
RF Cable	JYEBAO	0214/ C0050	Jan. 17, 2012	July 17, 2012
Test Software	Audix	e3/ Ver. 4.3.714.e	NCR	NCR
TR1 Semi - anechoic Chamber	ETS. LINDGREN	TR1/ 17627-B	April 23, 2011	April 23, 2012

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR : No Calibration Required.
- 3. The calibration date of the semi-anechoic chamber listed above is the date of NSA measurement.

☑ For Measurement at the distance of 3m

Test Site and	Manufacturer		Model No./	Last	Calibration
Equipment			Serial No.	Calibration Date	Due Date
EMI Test Receiver	R&S		ESCI/ 100019	May 25, 2011	May 25, 2012
Bi-Log Antenna	EMCO		3142C/ 52088	May 19, 2011	May 19, 2012
Horn Antenna	EMCO		3117/ 00082847	March 1, 2012	March 1, 2013
Bore-sight Antenna Mast	Sunol		TLT2/ 051110-5	NCR	NCR
	KMIC	□ KMA010180A01/ 99056		Oct. 12, 2011	Oct. 12, 2012
Dro Amplifiar	Mini Circuit		ZKL-2/ 004	Feb. 6, 2012	Aug. 6, 2012
Pre-Amplifier	MITEQ	V	JS4-00101800- 28-10P/1498979	Dec. 21, 2011	Dec. 21, 2012
	MITEQ		JS4-00101800- 28-5A/742309	Dec. 14, 2011	Dec. 14, 2012
Spectrum Analyzer	Agilent		E4407B/ MY45106795	May 2, 2011	May 2, 2012
RF Cable	N/A		N/A/ C0080	Feb. 6, 2012	Aug. 6, 2012
RF Cable	N/A		N/A/ C0081	April 16, 2012	Oct. 16, 2012
Test Software	Audix		e3/ Ver. 4.3.714.e	NCR	NCR
TR11 Semi - anechoic Chamber Note [:]	ETS. LINDGREN		TR11/ 906-A	April 22, 2012	April 22, 2013

- 1. The calibrations are traceable to NML/ROC.
- 2. NCR : No Calibration Required.
- 3. The calibration date of the semi-anechoic chamber listed above is the date of NSA measurement.

Measurement Uncertainty

The assessed measurement uncertainty with a suitable coverage factor K to ensure 95% confidence level for the normal distribution are shown as below, the values are less than U_{cispr} in table 1 of CISPR 16-4-2.

Test Site	Polarization	Frequen	cy Range
(Measuring distance)		30MHz ~200MHz	200MHz ~1000MHz
TR1(10m)	Horizontal	3.2dB	3.5dB
	Vertical	3.3dB	3.6dB
TR11(3m)	Horizontal	3.8 dB	4.1dB
	Vertical	3.3dB	3.7dB

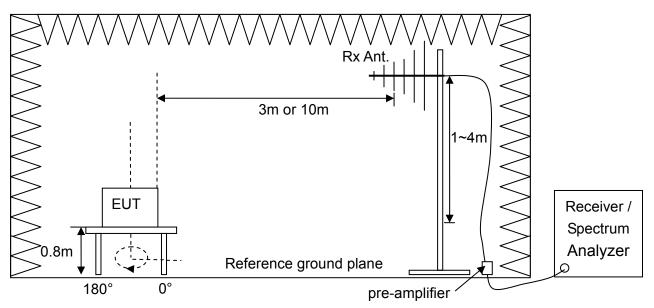
Test Site	Polarization	Frequency Range				
(Measuring distance)	r olarization	1GHz ~18GHz	18GHz~26GHz			
TR11(3m)	Horizontal	3.5dB	4.4dB			
	Vertical	3.6dB	4.5dB			

3.3 Test Procedures

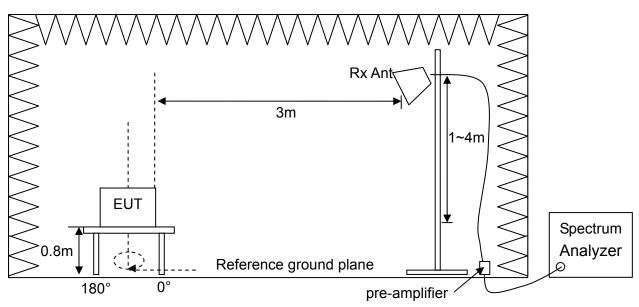
- a. The EUT was set up per the test configuration figured in the next section of this chapter to simulate the typical usage per the user's manual.
- b. If the EUT is tabletop equipment, it was placed on a non-conducted table with a height of 0.8 meters above the reference ground plane in the semi-anechoic chamber. If the EUT is floor-standing equipment, it was placed on a non-conducted support with a height of 12 millimeters above the reference ground plane in the semi-anechoic chamber.
- c. For the measurement of frequency below 1000MHz, the EUT was set 10m away from the interference receiving antenna for the limit of Class A equipment or CISPR 22. For Class B equipment and the measurement of frequency above 1000MHz, the EUT was set 3m away from the interference receiving antenna.
- d. Rapidly sweep the signal in the test frequency range by using the spectrum through the Maximum-peak detector.
- e. Rotate the EUT from 0° to 360° and position the receiving antenna at heights from 1 to 4 meters above the reference ground plane continuously to determine at least six frequencies associated with higher emission levels and record them.
- f. For measurement of frequency above 1000MHz, the beamwidth of receiving horn antenna should keep covering EUT when the receiving horn antenna height varied.
- g. Then measure each frequency found from step e. by using the spectrum with rotating the EUT and positioning the receiving antenna height to determine the maximum level.
- h. Finely tune the antenna and turntable around the recorded position of each frequency found from step f.
- i. For measurement of frequency below 1000MHz, set the receiver detector to be Quasi-Peak per CISPR 16-1 to find out the maximum level occurred.
- j. For measurement of frequency above 1000MHz, set the spectrum detector to be Peak or Average to find out the maximum level occurred, if any.
- k. Record frequency, azimuth angle of the turntable, height, and polarization of the receiving antenna and compare the maximum level with the required limit.
- I. Change the receiving antenna to another polarization to measure radiated emission by following step d. to k. again.
- m. If the peak emission level measured from step e. is 4dB lower than the limit specified, then the emission values presented will be the peak value only. Otherwise, accurate Q.P. value will be measured and presented.

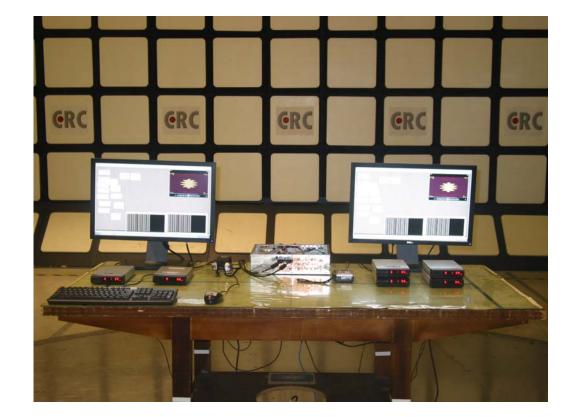
3.4 Test Configurations

Radiated Emission Measurement below 2000MHz



Radiated Emission Measurement above 1000MHz (if any)





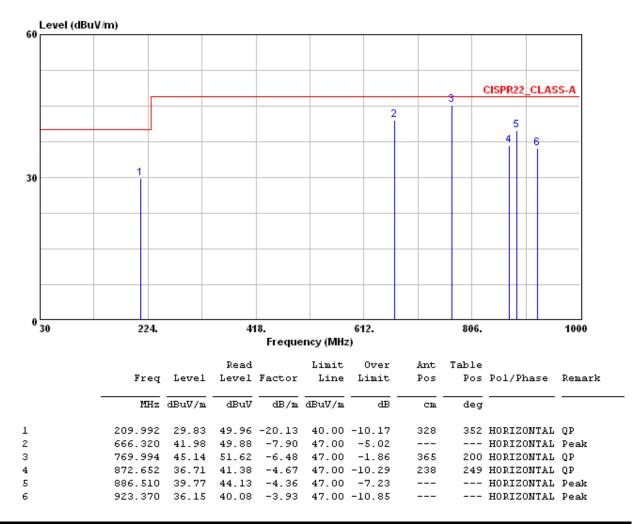
3.5 Photographs of the Test Configurations



3.6 Test Results

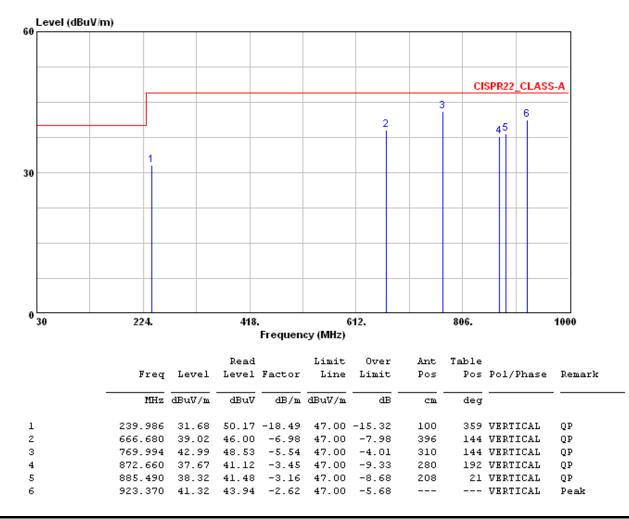
Radiated Emission Measurement below 1000MHz

IF Bandwidth	:	120kHz	Polarization	:	Horizontal			
Humidity	:	58%RH	Frequency Range	:	30MHz~1GHz			
Tester	:	Meng	Temperature	:	27°C			
Test Voltage	:	120V/60Hz to	20V/60Hz to the power adapter					
Test Mode	:	As description of section 1.2						



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.
- 3. Q.P is abbreviation of quasi-peak.

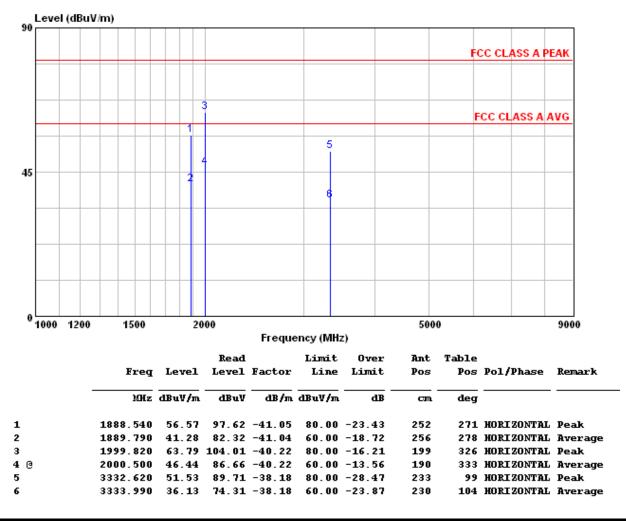
Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to	120V/60Hz to the power adapter				
Tester	:	Meng	Temperature	:	27°C		
Humidity	:	58%RH	Frequency Range	:	30MHz~1GHz		
IF Bandwidth	:	120kHz	Polarization	:	Vertical		



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.
- 3. Q.P is abbreviation of quasi-peak.

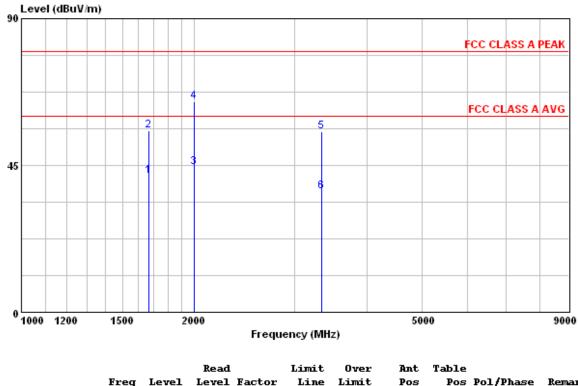
Radiated Emission Measurement above 1000MHz

Test Mode	:	As description of section 1.2						
Test Voltage	:	120V/60Hz to	120V/60Hz to the power adapter					
Tester	:	Meng	Temperature	:	27°C			
Humidity	:	58%RH	Frequency Range	:	1GHz ~9GHz			
IF Bandwidth	:	1MHz	Polarization	:	Horizontal			



- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.

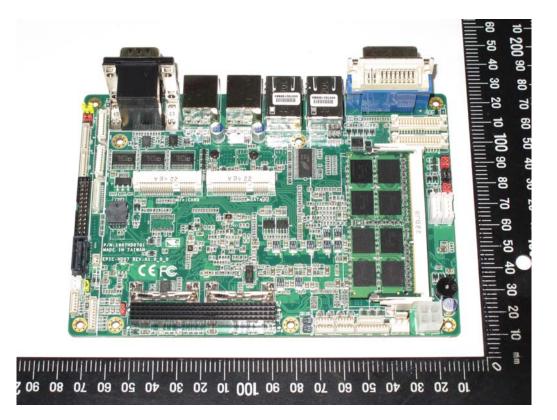
Test Mode	:	As description of section 1.2					
Test Voltage	:	120V/60Hz to	120V/60Hz to the power adapter				
Tester	:	Meng	Temperature	:	27°C		
Humidity	:	58%RH	Frequency Range	:	1GHz ~9GHz		
IF Bandwidth	:	1MHz	Polarization	:	Vertical		



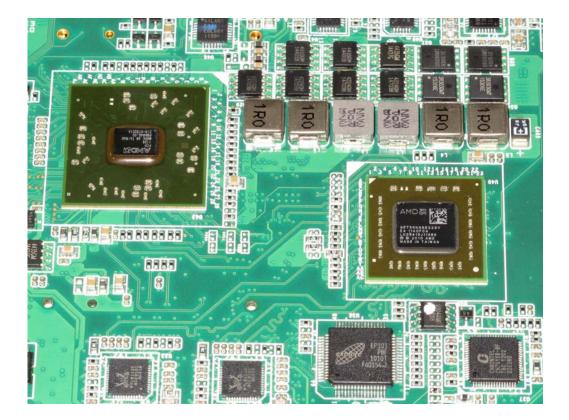
			Read		Limit	0ver	Ant	Table	_	
	Freq	Level	Level	Factor	Line	Limit	Pos	Pos	Pol/Phase	Remark
	MHz	dBuV/m	dBuV	dB/m	dBuV/m	dB	cm	deg		
1	1665.190	41.87	84.76	-42.89	60.00	-18.13	160	45	VERTICAL	Average
2	1666.770	55.57	98.45	-42.88	80.00	-24.43	164	39	VERTICAL	Peak
3	1998.580	44.46	84.69	-40.23	60.00	-15.54	150	146	VERTICAL	Average
4	1999.560	64.50	104.72	-40.22	80.00	-15.50	159	138	VERTICAL	Peak
5	3333.300	55.39	93.57	-38.18	80.00	-24.61	160	153	VERTICAL	Peak
6	3334.890	36.92	75.10	-38.18	60.00	-23.08	165	158	VERTICAL	Average

- 1. Emission Level = reading value + correction factor.
- 2. Correction factor = cable loss + antenna factor gain of pre-amplifier.

Attachment 1 Photographs of EUT

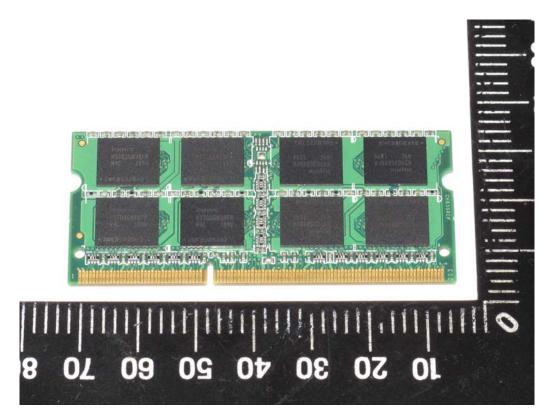






Support Units





Attachment 2 Modifications of EUT

Statement of the EUT Modifications

According to the rules of ANSI C63.4-2003 clause 10.1.13, the following equipment (EUT):

Product	:	EPIC Express Board
Model No.	:	xxxxxEPIC-HD07-xxxxxx
		(Where x is 0-9 $,$ A-Z $,$ -or blank) for marketing purpose
Manufacturer	:	AAEON Technology Inc.
Address	:	5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien Dist, New
		Taipei City, Taiwan, R.O.C.

□ should be <u>without</u> any modifications made

 \Box should be <u>with</u> some modifications made

to bring the EUT into compliance with the appropriate specifications (47CFR Part 15, Subpart B). If any, the details of the modifications including the complete descriptions, reasons and so on are described in next page of this report.

We , <u>AAEON Technology Inc.</u> hereby ensure that the product specified above will have all of the modifications incorporated in the product when manufactured and placed on the market.

The following importer or manufacturer is responsible for this statement:

Title / Name (full name)			Date			
Legal Signature of the responsible personal:						
Telephone	:	E-mail:				
Company Address	:					
Company Name	:					

The details of the modifications:

Item	Solution Component	Specifications	Manufacturer	Quantity	Reasons
1					
2					
3					
4					
5					
6					
7					
8					
9					
10					
11					
12					
13					
14					
15					

If needed, some modification items are shown in the photographs in the following.